

MBN1200H45E2

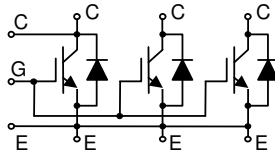
Target Specification

Silicon N-channel IGBT 4500V E2 version

FEATURES

- * Low conduction loss IGBT module.
- * Low noise due to ultra soft fast recovery diode.
- * High reliability, high durability module.
- * High thermal fatigue durability.
($\Delta T_c=70^\circ\text{C}$, $N>30,000$ cycles)
- * Isolated heat sink (terminal to base).

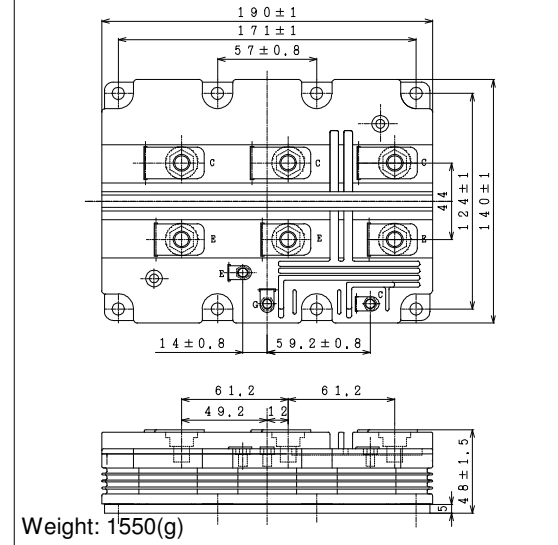
CIRCUIT DIAGRAM



TERMINALS

OUTLINE DRAWING

Unit in mm



ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$)

Item	Symbol	Unit	MBN1200H45E2
Collector Emitter Voltage	V_{CES}	V	4,500
Gate Emitter Voltage	V_{GES}	V	± 20
Collector Current	DC	I_C	1,200 ($T_c=80^\circ\text{C}$)
	1ms	I_{Cp}	2,400
Forward Current	DC	I_F	1,200
	1ms	I_{FM}	2,400
Junction Temperature	T_j	$^\circ\text{C}$	-40 ~ +125
Storage Temperature	T_{stg}	$^\circ\text{C}$	-50 ~ +125
Isolation Voltage	V_{ISO}	V_{RMS}	8,400 (AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/10 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value $1.8\pm 0.2/9\pm 1\text{N}\cdot\text{m}$

(2) Recommended Value $5.5\pm 0.5\text{N}\cdot\text{m}$

ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I_{CES}	mA	-	-	25	$V_{CE}=4,500\text{V}$, $V_{GE}=0\text{V}$, $T_j=25^\circ\text{C}$
			-	25	100	$V_{CE}=4,500\text{V}$, $V_{GE}=0\text{V}$, $T_j=125^\circ\text{C}$
Gate Emitter Leakage Current	I_{GES}	nA	-500	-	+500	$V_{GE}=\pm 20\text{V}$, $V_{CE}=0\text{V}$, $T_j=25^\circ\text{C}$
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	TBD	3.7	4.2	$I_C=1200\text{A}$, $V_{GE}=15\text{V}$, $T_j=125^\circ\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(TO)}$	V	5.4	6.4	7.4	$V_{CE}=10\text{V}$, $I_C=1200\text{mA}$, $T_j=25^\circ\text{C}$
Input Capacitance	C_{ies}	nF	-	155	-	$V_{CE}=10\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$, $T_j=25^\circ\text{C}$
Internal Gate Resistance	R_{ge}	Ω	-	0.8	-	$V_{CE}=10\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$, $T_j=25^\circ\text{C}$
Switching Times	Rise Time	t_r	1.0	2.0	3.0	$V_{CC}=2,600\text{V}$, $I_C=1200\text{A}$ $L_S=150\text{nH}$ $R_G=3.3\Omega$ (3) $V_{GE}=\pm 15\text{V}$, $T_j=125^\circ\text{C}$
	Turn On Time	t_{on}	1.4	2.7	4.0	
	Fall Time	t_f	1.5	3.0	4.5	
	Turn Off Time	t_{off}	3.6	5.5	8.0	
Peak Forward Voltage Drop	V_{FM}	V	TBD	2.9	3.4	$I_F=1200\text{A}$, $V_{GE}=0\text{V}$, $T_j=125^\circ\text{C}$
Reverse Recovery Time	t_{rr}	μs	-	0.8	1.6	$V_{CC}=2600\text{V}$, $I_F=1200\text{A}$, $L_S=150\text{nH}$ $T_j=125^\circ\text{C}$
Turn On Loss	$E_{on(10\%)}$	J/p	-	3.9	5.8	$V_{CC}=2600\text{V}$, $I_C=I_F=1200\text{A}$, $L_S=150\text{nH}$ $R_G=3.3\Omega$ (3) $V_{GE}=\pm 15\text{V}$, $T_j=125^\circ\text{C}$
	$E_{on(full)}$	J/p	-	4.3	-	
Turn Off Loss	$E_{off(10\%)}$	J/p	-	4.2	6.3	
	$E_{off(full)}$	J/p	-	4.8	-	
Reverse Recovery Loss	$E_{rr(10\%)}$	J/p	-	3.2	4.8	
	$E_{rr(full)}$	J/p	-	3.5	-	

Notes:(3) R_G value is the test condition's value for evaluation of the switching times, not recommended value.

Please, determine the suitable R_G value after the measurement of switching Waveforms (overshoot voltage, etc.) with appliance mounted.

* Please contact our representatives at order.

* For improvement, specifications are subject to change without notice.

* For actual application, please confirm this spec sheet is the newest revision.

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Target Specification

THERMAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Thermal Impedance	IGBT	Rth(j-c)	-	-	0.0085	Junction to case
	FWD	Rth(j-c)	-	-	0.017	
Contact Thermal Impedance		Rth(c-f)	-	0.005	-	Case to fin ($\lambda_{grease}=1W/(m \cdot K)$, heat-sink flatness $\leq 50\mu m$)

DEFINITION OF TEST CIRCUIT

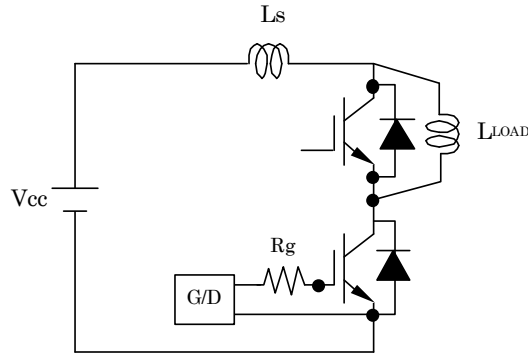


Fig.1 Switching test circuit

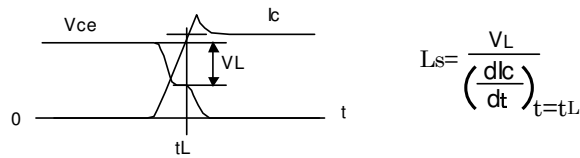


Fig.2 Definition of Ls

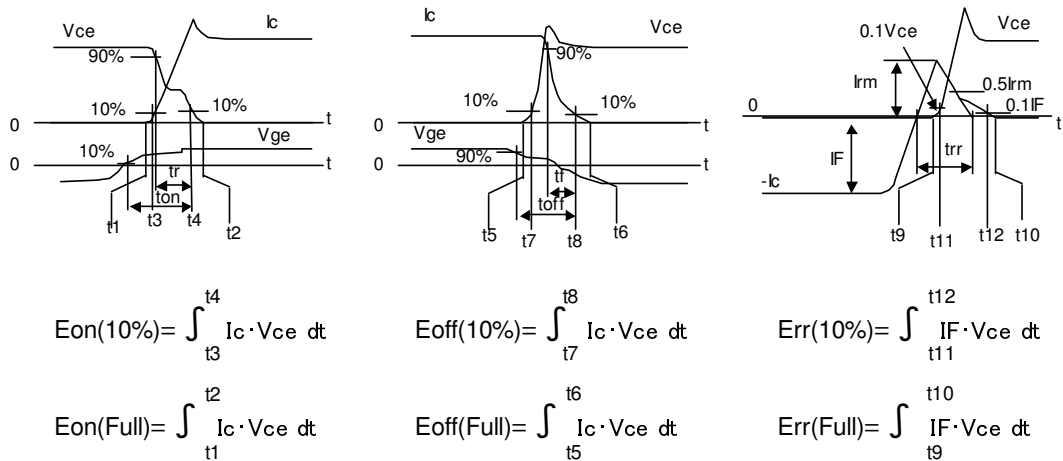
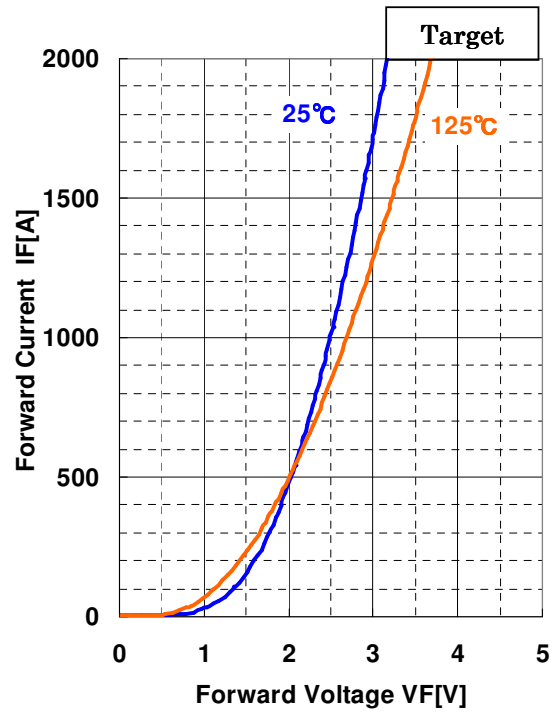
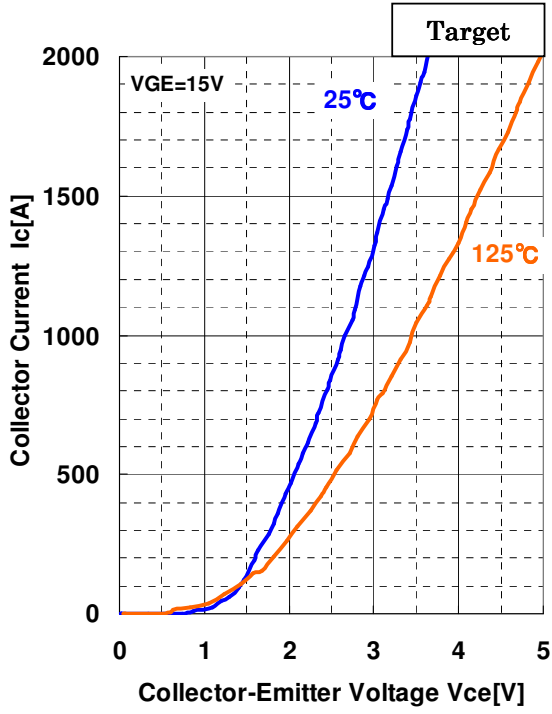


Fig.3 Definition of switching loss

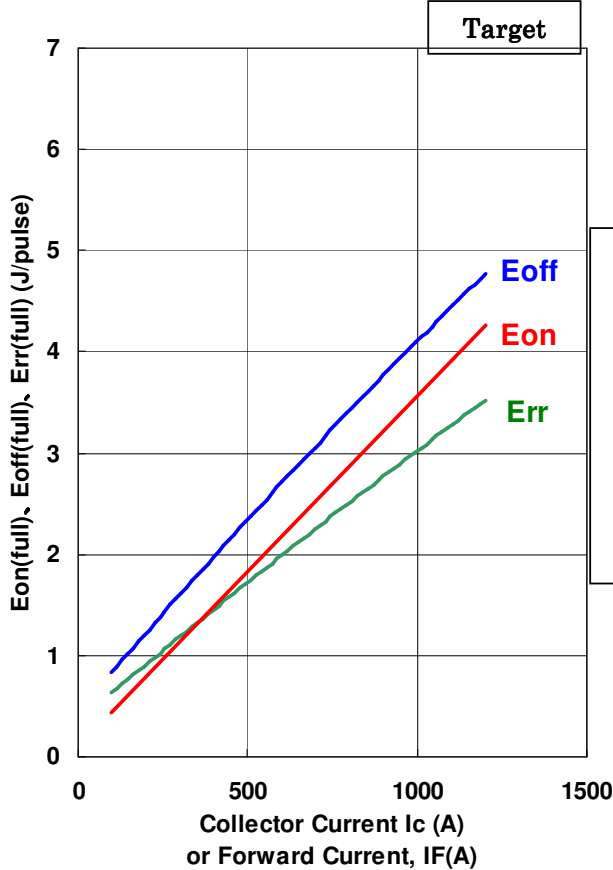
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Target Specification

STATIC CHARACTERISTICS



DYNAMIC CHARACTERISTICS

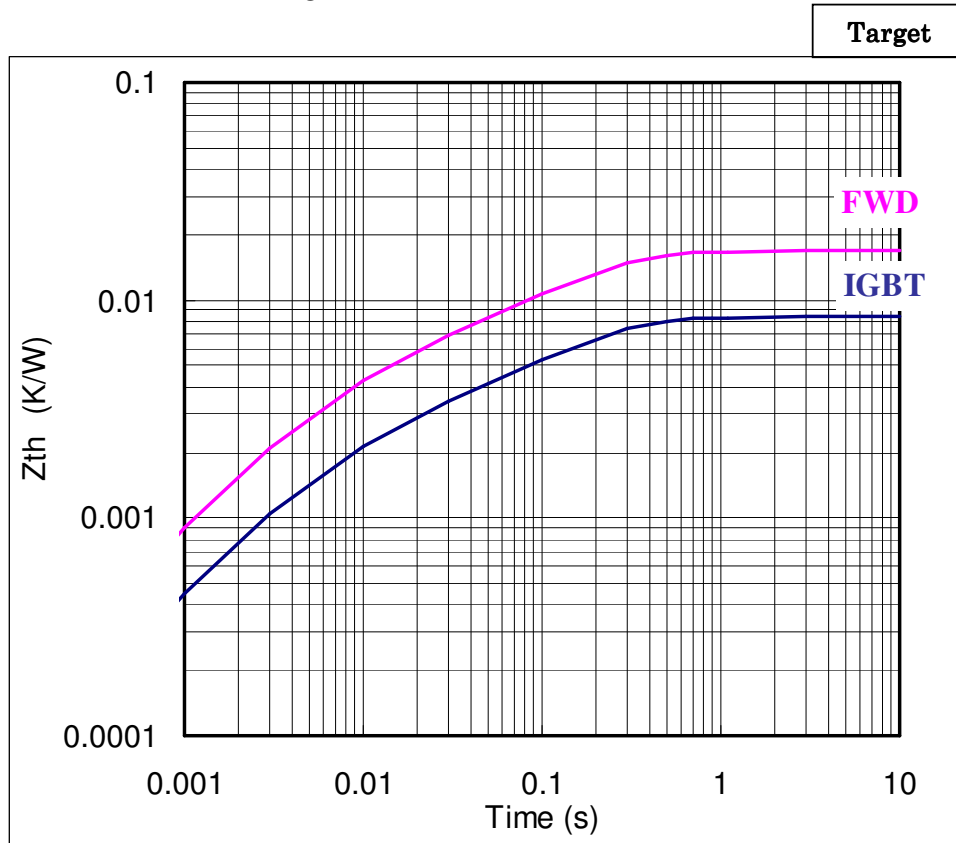


【Conditions】
 Tj=125°C
 Vcc=2600V
 L=150nH
 RG(on/off)=3.3/3.3 Ω
 VG=±15V
 Inductive Load

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Target Specification

TRANSIENT THERMAL IMPEDANCE



Transient Thermal Impedance Curve (Maximum Value)

● **Negative environmental impact material**

Please note that following materials are contained in the product
In order to keep characteristics and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder
Arsenic and its compounds	Si chip

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Target Specification

HITACHI POWER SEMICONDUCTORS

Notices

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